



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AO4832**

**30V Dual N-Channel MOSFET**

### General Description

The AO4832 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for high side switch in SMPS and general purpose applications.

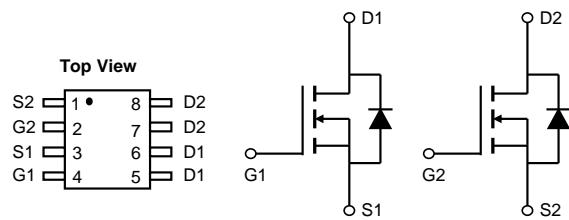
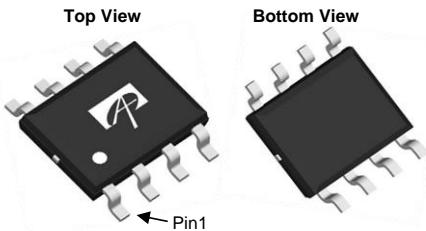
### Product Summary

|                                  |          |
|----------------------------------|----------|
| $V_{DS}$                         | 30V      |
| $I_D$ (at $V_{GS}=10V$ )         | 10A      |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 13mΩ   |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 17.5mΩ |

100% UIS Tested  
100%  $R_g$  Tested



SOIC-8



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                              | Symbol           | Maximum    | Units |
|--|------------------|------------|-------|
| Drain-Source Voltage                   | $V_{DS}$         | 30         | V     |
| Gate-Source Voltage                    | $V_{GS}$         | $\pm 20$   | V     |
| Continuous Drain Current <sup>A</sup>  | $I_D$            | 10         | A     |
| Current <sup>B</sup>                   |                  | 8          |       |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$         | 55         |       |
| Avalanche Current <sup>C</sup>         | $I_{AS}, I_{AR}$ | 22         | A     |
| Avalanche energy L=0.1mH <sup>C</sup>  | $E_{AS}, E_{AR}$ | 24         | mJ    |
| Power Dissipation <sup>B</sup>         | $P_D$            | 2          | W     |
| Power Dissipation <sup>B</sup>         |                  | 1.3        |       |
| Junction and Storage Temperature Range | $T_J, T_{STG}$   | -55 to 150 | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ             | Max  | Units |
|--|-----------------|-----------------|------|-------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 48              | 62.5 | °C/W  |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 74              | 90   | °C/W  |
| Maximum Junction-to-Lead                   | Steady-State    | $R_{\theta JL}$ | 32   | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min | Typ          | Max      | Units            |
|-----------------------------|---------------------------------------|---|-----|--------------|----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |              |          |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$  | 30  |              |          | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$               |     |              | 1<br>5   | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$                                      |     |              | 100      | nA               |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$   | 1.5 | 1.9          | 2.5      | V                |
| $I_{D(\text{ON})}$          | On state drain current                | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$   | 55  |              |          | A                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=10\text{A}$<br>$T_J=125^\circ\text{C}$                |     | 10.8<br>15.5 | 13<br>19 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=8\text{A}$   |     | 14           | 17.5     | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=10\text{A}$  |     | 43           |          | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$   |     | 0.75         | 1        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |     |              | 2.5      | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |              |          |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$                          | 610 | 760          | 910      | pF               |
| $C_{oss}$                   | Output Capacitance                    |   | 88  | 125          | 160      | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |   | 40  | 70           | 100      | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$                           | 0.8 | 1.6          | 2.4      | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |              |          |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=10\text{A}$                        | 11  | 14           | 17       | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   | 5   | 6.6          | 8        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |   |     | 2.4          |          | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |   |     | 3            |          | nC               |
| $t_{D(\text{on})}$          | Turn-On DelayTime                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1.5\Omega, R_{\text{GEN}}=3\Omega$ |     | 4.4          |          | ns               |
| $t_r$                       | Turn-On Rise Time                     |   |     | 9            |          | ns               |
| $t_{D(\text{off})}$         | Turn-Off DelayTime                    |   |     | 17           |          | ns               |
| $t_f$                       | Turn-Off Fall Time                    |   |     | 6            |          | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=10\text{A}, dI/dt=500\text{A}/\mu\text{s}$                               | 5.6 | 7            | 8        | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=10\text{A}, dI/dt=500\text{A}/\mu\text{s}$                               | 6.4 | 8            | 9.6      | nC               |

A. The value of  $R_{\text{IJL}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\text{IJL}}$  is the sum of the thermal impedance from junction to lead  $R_{\text{IJL}}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

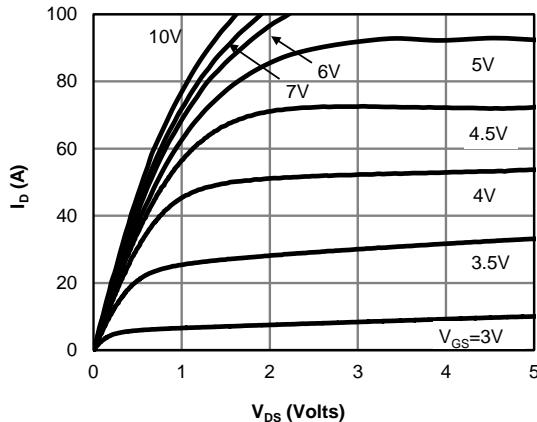
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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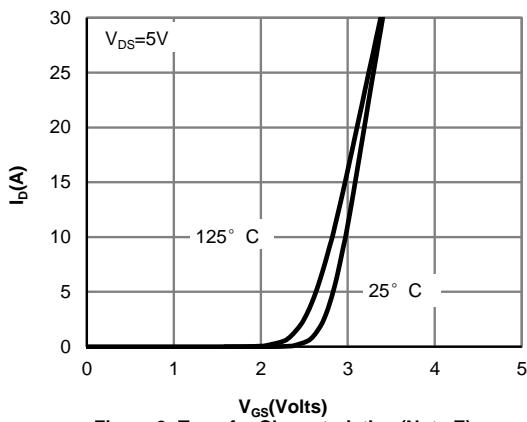
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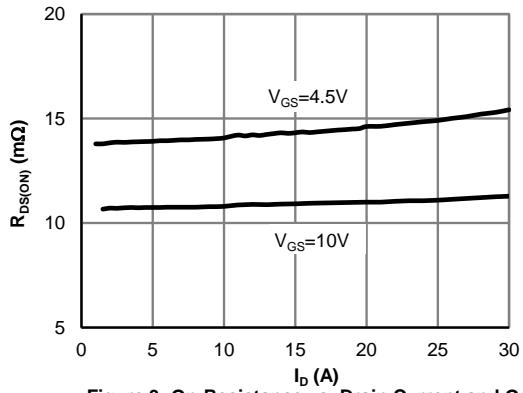
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



**Fig 1: On-Region Characteristics (Note E)**



**Figure 2: Transfer Characteristics (Note E)**



**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

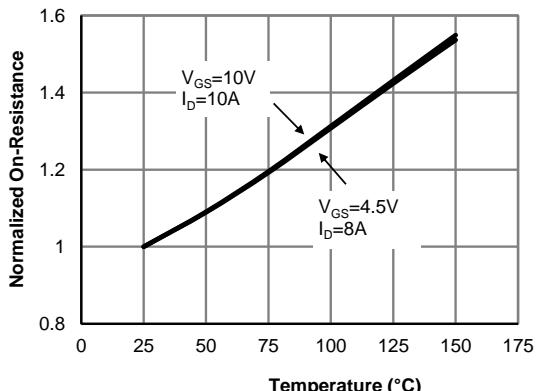
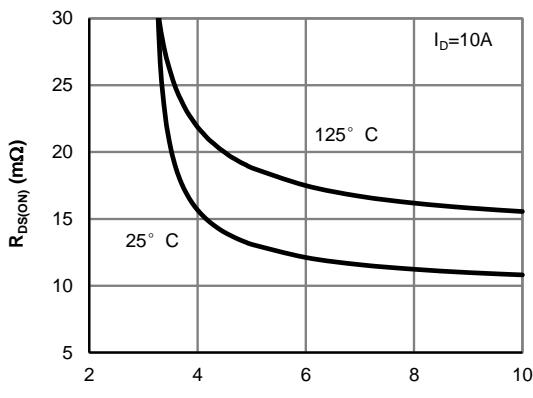


Figure 4: On-Resistance vs. Junction Temperature  
(Note E)



**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

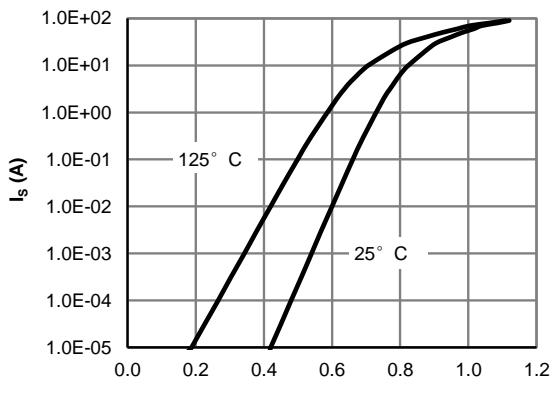
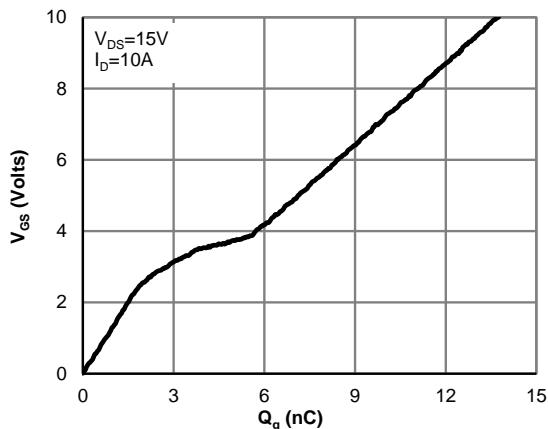
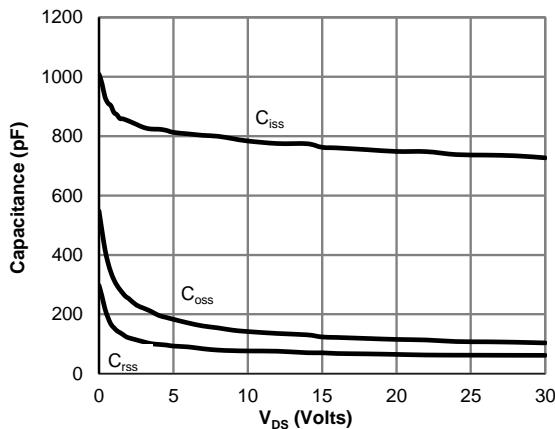
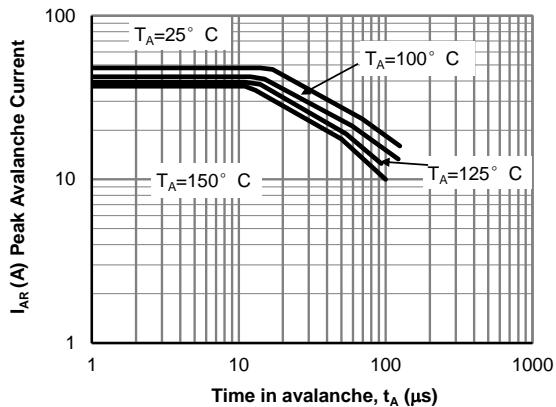
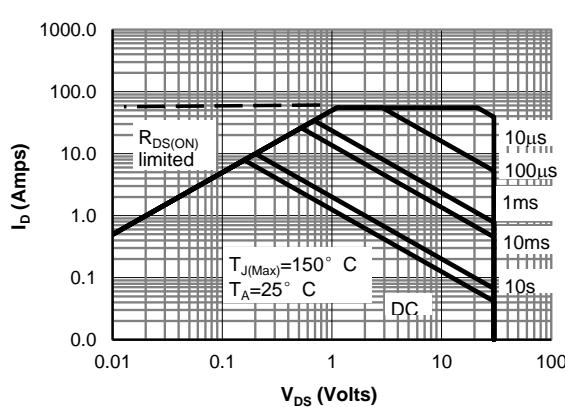
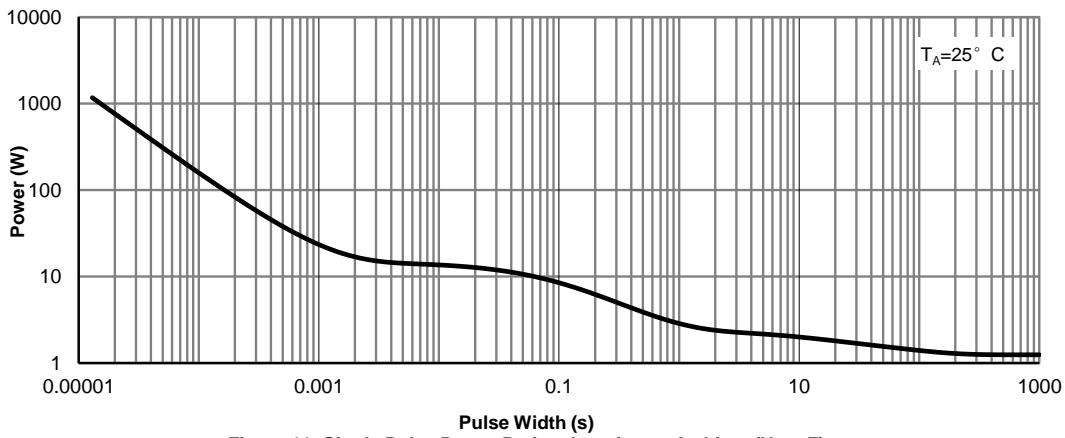


Figure 6. Back Bias to Characterization (Note E).

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Single Pulse Avalanche capability (Note C)**

**Figure 10: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)**

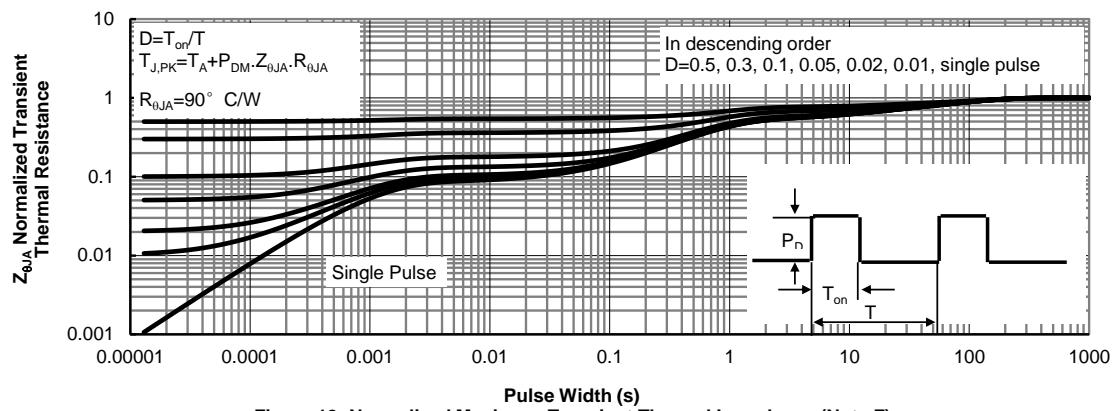
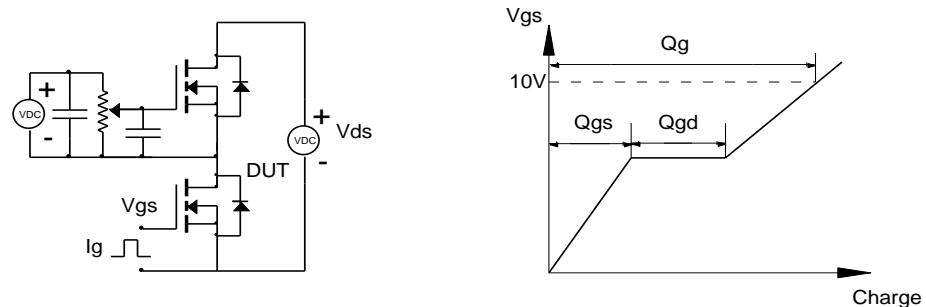
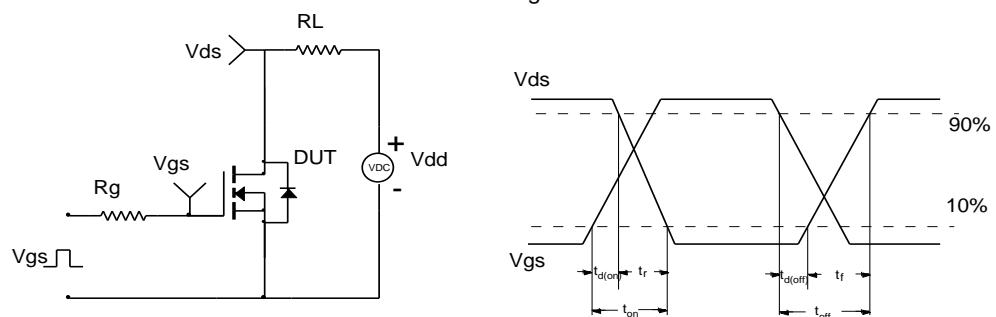
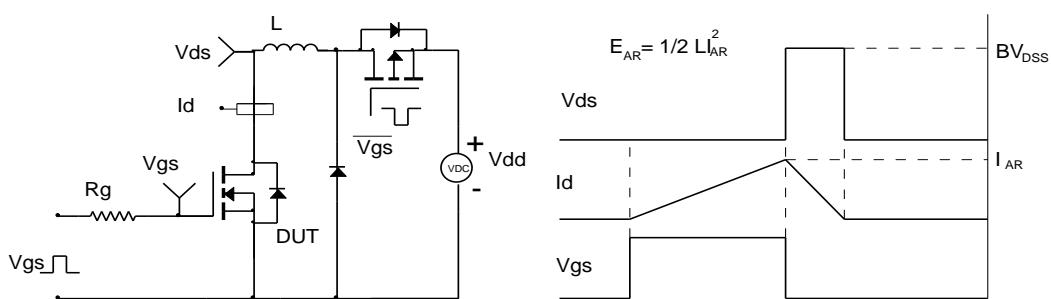
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**
